

Fig. 6 Pressure-Load calibration curve at low temperature

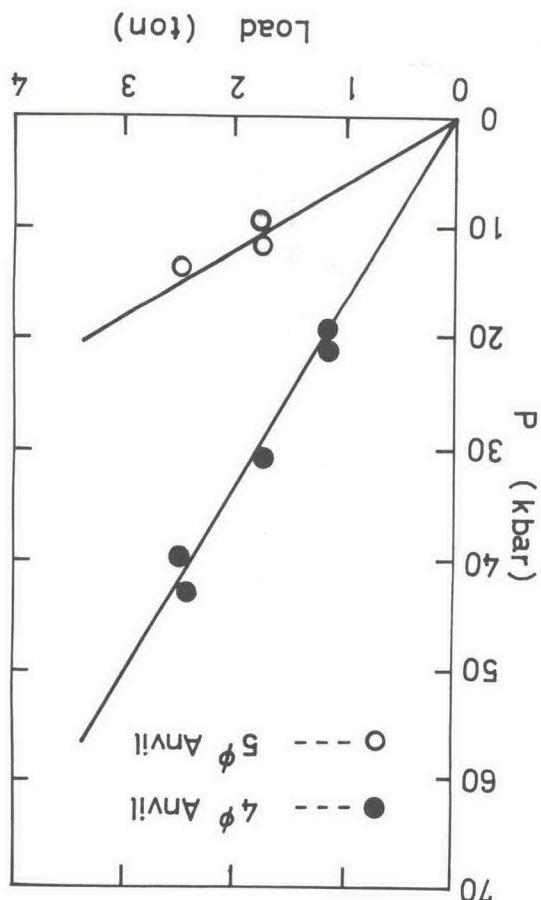


Fig. 5 Pressure-Load calibration curve at room temperature ( $4\frac{1}{2}$  Bridgeman anvil)

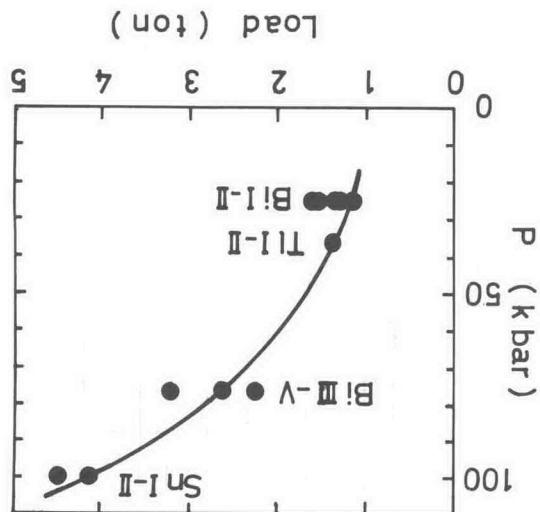
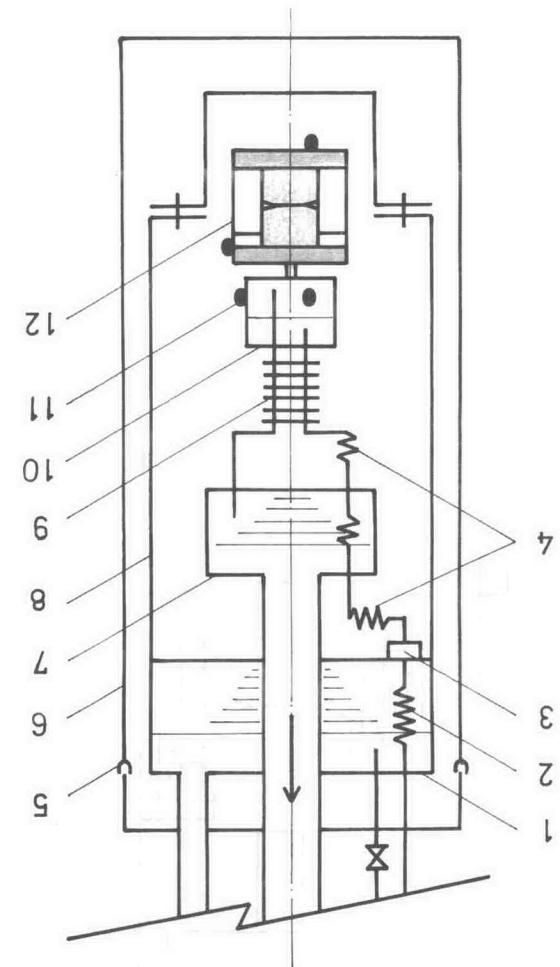


Fig. 4 Dilution cryostat for high pressure experiments



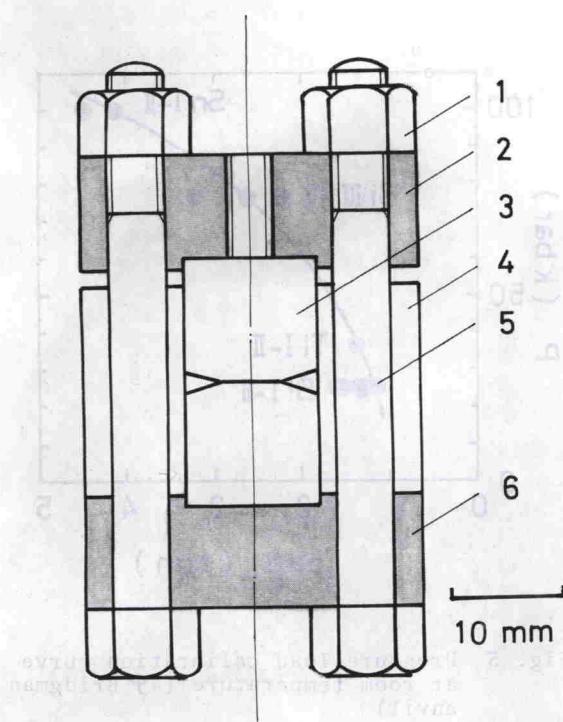


Fig. 1 D-I type high pressure clamp cell  
This cell is used for a.d.c.  
electrical resistance measurement

1. Fixing nut
2. Upper flange
3. Tungsten carbide anvil
4. Anvil guide
5. Fixing bolt
6. Lower flange

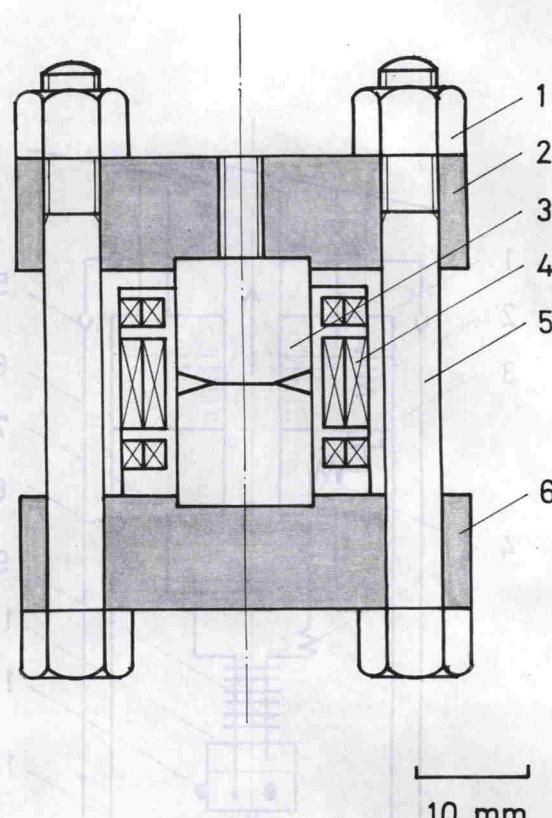


Fig. 2 D-II type high pressure clamp cell  
This cell is used for an a.c.  
magnetic susceptibility measure-  
ment

1. Fixing nut
2. Upper flange
3. Tungsten carbide anvil
4. Measuring coil
5. Fixing bolt
6. Lower flange

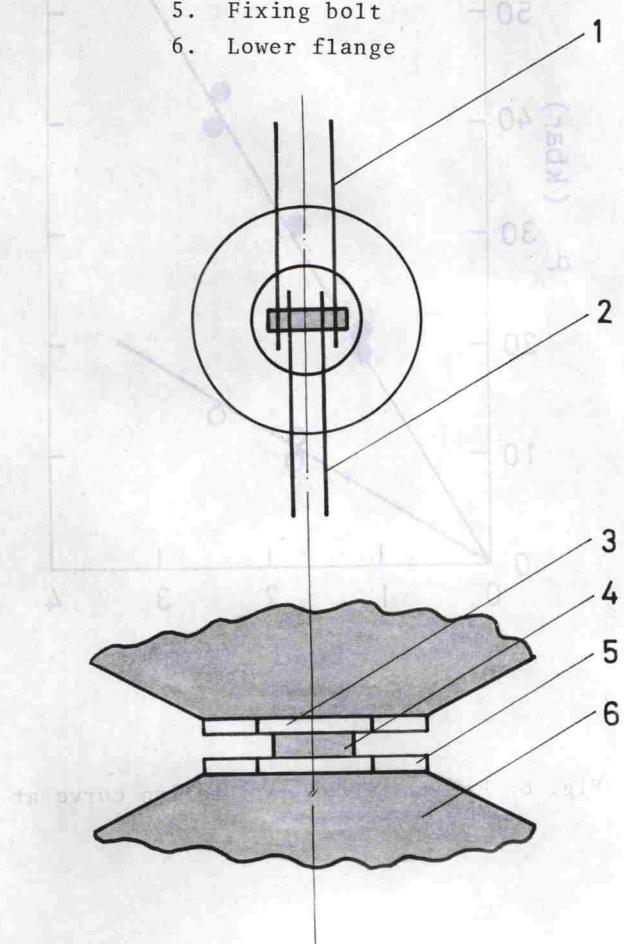


Fig. 3 Sample assembly for d.c. method

1. Current lead
2. Potential lead
3. Talc disk
4. Sample
5. Phyrophyllite ring
6. Tungsten carbide anvil